

<b>Notice of References Cited</b>	Application/Control No. 10/578,578	Applicant(s)/Patent Under Reexamination ERIKSEN, ANDRE SLOTH	
	Examiner Teresa J. Walberg	Art Unit 3744	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,316,077	05-1994	Reichard, Jeffrey A.	165/104.28
*	B	US-5,441,102	08-1995	Burward-Hoy, Trevor	165/104.25
*	C	US-5,763,951	06-1998	Hamilton et al.	257/714
*	D	US-6,408,937	06-2002	Roy, Sanjay K.	165/104.33
*	E	US-6,580,610	06-2003	Morris et al.	361/699
*	F	US-6,702,002	03-2004	Wang, Chin-Wen	165/80.3
*	G	US-6,952,345	10-2005	Weber et al.	361/699
*	H	US-7,055,581	06-2006	Roy, Sanjay K.	165/104.33
*	I	US-2003/0056939	03-2003	Chu et al.	165/80.4
*	J	US-2004/0042176	03-2004	Niwatsukino et al.	361/699
*	K	US-2006/0169440	08-2006	Chou et al.	165/104.33
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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